

# Search Notes



Application/Control No.

10/604,671

Examiner

Christopher Verdier

Applicant(s)/Patent under  
Reexamination

LIU ET AL.

Art Unit

3745

## SEARCHED

Class	Subclass	Date	Examiner
415	175-176, 178, 204, 206, 208.1	3/29/2006	CV
415	101-102	3/29/2006	CV
415	211.1	3/29/2006	CV
415	228	3/29/2006	CV
416	185, 186R	3/29/2006	CV
416	187-188	3/29/2006	CV
416	223B, 238	3/29/2006	CV
416	242	3/29/2006	CV
62	180, 186	3/29/2006	CV
<i>Search is updated</i>			
		<i>5/3/07 JTC</i>	

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
<i>ECPT interference search see attached paper 5/3/07 JTC</i>			

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
Consulted: Tanner - 62	3/29/2006	CV
Inventor name search (EAST - USPAT, USPGPUB) - see attached search history	3/29/2006	CV
Inventor name search (PALM) - see attached search history	3/29/2006	CV